PTS Josef Solnař, s.r.o.

Facility No. 2355, Calibration Laboratory U Hrůbků 170/18, Nová Ves, 709 00 Ostrava

CMC for the field of measured quantity: Testing of properties and defects of materials

num- ber ¹	Calibrated quantity / Subject of calibration	Nom	ninal r		unit	Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty	Calibration principle	Calibration procedure	Work
		min. unit		max.	unit	1	specified ²		identification ³	piace
1*	Ultrasonic defectoscopes								A 04-55/31	
	Stability – measurement of amplitude	0 % SH	to	100 (% SH		1 4 9 / 6 1	Signal generation by reference generator		
	Stability massurament of nacition						1.4 % SH	(ČSN EN 12668-1:2010)		
	Stability - measurement of position Transmitter - Impulse voltage amplitude	0 % SW	to	100 \	% SW		1.1 % SW	Direct signal measurement with a reference oscilloscope		
		1 V	to	400	V		3.2 %	(ČSN EN 12668-1:2010)		
	Transmitter – Pulse decay amplitude	1 V	to	400	V		3.2 %	,		
	Transmitter – Pulse rise time	0 ns	to	500 ı	ns		2.7 % + 2.4 ns			
	Transmitter – Pulse duration	0 ns	to	500 ı	ns		2.7% + 2.4 ns			
	$Receiver-f_{lm},\ lower\ limit\ frequency$	0.1.244						Signal generation by a reference generator		
	Descious Com I' '4 C	0.1 MHz	to		MHz		3.3 %	(ČSN EN 12668-1:2010)		
	Receiver – fum, upper limit frequency	0.1 MHz	to		MHz		3.3 %			
	Receiver – f0, medium frequency	0.1 MHz	to		MHz		3.5 %			
	Receiver – Δf , bandwidth	0.1 MHz	to	25 I	MHz		4.7 %			
	Receiver – Equivalent input noise level	10 ⁻¹² V/√Hz	to	10 ⁻⁶ V	V/\/Hz	* DTO 34.	2.7·10 ⁻⁹ V/√Hz	Direct signal measurement with a reference oscilloscope, Comparison with a reference attenuator (ČSN EN 12668-1:2010)		

The Appendix is an integral part of Certificate of Accreditation No. 565/2022 of 29/11/2022

Accredited entity according to ČSN EN ISO/IEC 17025:2018:

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Ord.	Calibrated quantity / Subject of calibration		Nomi	inal r	ange	Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty specified ²	Calibration principle	Calibration procedure identification ³	Work place
ber ¹		min.	unit		max. unit					
	Receiver – Attenuator accuracy							Comparison with a		
		0 dl	D	4-	70 ID			reference attenuator		
	Receiver – Vertical linearity	0 d1		to	70 dB		2.8 % + 0.2 dB	(ČSN EN 12668-1:2010)		
	, ,	U di	3	to	70 dB		2.8 % + 0.2 dB			
	Time base linearity for digital instruments							Signal generation by		
	mstruments	0.5 με	2	to	2,000 μs		1 1 0/ + 0 05	reference generator		
2*	Ultrasonic thickness gauges	0.5 με		-10	2,000 μs		1.1 % + 0.05 μs	(ČSN EN 12668-1:2010)		
_	Low voltage warning								A 04-55/01	
	Low voltage warming							Direct measurement of		
								voltage and current with a reference multimeter		
		1 V		to	20 V		0.87 %	(ČSN EN 15317)		
	Voltage operating range	1 V		to	20 V		0.87 %	(001, 21, 1001,)		
	Current operating range	20 m	A	to	2,000 mA		0.43 %			
	Transmitter – Pulse repeating period				,			Direct signal measurement		
								with a reference		
								oscilloscope		
		0.1 m	S	to	10 ms		0.50 %	(ČSN EN 15317)		
	Transmitter – Impulse voltage amplitude	1 V		to	400 V		3.2 %			
	Transmitter – Pulse decay amplitude	1 V		to	400 V		3.2 %			
	Transmitter – Pulse rise time	0 ns		to	500 ns		2.7 % + 2.4 ns			
	Transmitter – Pulse duration	0 ns		to	500 ns		2.7 % + 2.4 ns			
	Min. and max. measurable thickness							Comparison with a length		
		1 m	m	to	100 mm		0.04 mm	standard (ČSN EN 15317)		
	Thickness resolution				0.1 mm	th: (9.4 to 9.8) mm	0.04 mm			

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Ord.	Calibrated quantity / Subject of calibration		Nomi	nal r	ange		Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty specified ²	Calibration principle	Calibration procedure identification ³	Work
ber ¹		min. u	ınit		max.	unit					place
3*	Tangential magnetic field / Hand magnets	1.5 kA	/m	to	15 1	kA/m	50 Hz	7.7 %	Measurement by a teslameter (ČSN EN ISO 9934-3)	A 04-53/41a	
4*	AC current / Current generators	0 A		to	2,000	A	50 Hz	4.9 % + 8 A	Comparison with a clamp ammeter (ČSN EN ISO 9934-3)	A 04-53/51a	
5*	Stationary magnetization equipment									A 04-53/61a	
	Tangential magnetic field	2 kA	/m	to	6 1	κΑ/m	50 Hz	7.7 %	Measurement by a teslameter (ČSN EN ISO 9934-3)		
	AC current	0 A		to	2,000 /	A	50 Hz	4.9 % + 8 A	Comparison with a clamp ammeter (ČSN EN ISO 9934-3)		
6*	Meters of magnetic field intensity (teslameters, gaussmeters, magnetometers) DC tangential magnetic field		,						Comparison with coil magnetic induction standard	A 04-53/32	
	AC tangential magnetic field	0.5 kA/ 0.5 kA/		to to		A/m	50 II-	2.0 %	(ČSN EN ISO 9934-3)		
	DC tangential magnetic field	1.5 kA/		to to		A/m A/m	50 Hz	3.0 % 0.8 %			
	AC tangential magnetic field	1.5 kA/		to		A/m	50 Hz	1.2 %			



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Ord. 1um-	Calibrated quantity / Subject of calibration -	Nor	ninal r	ange		Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty specified ²	Calibration principle	Calibration procedure identification ³	Worl
ber ¹		min. unit		max.	unit					
7*	Eddy current defectoscopes								A 04-51/29	
	Generator frequency	0.1 kHz	to	1,000	kHz		0.011 %	Direct signal measurement with a reference counter (ČSN EN 15548-1:2010)		
	Receiver $- f_{lm}$, lower limit frequency	1 kHz	to	100	Ма		2.40/	Signal generation by a reference generator		
	Receiver – f _{um} , upper limit frequency	1 kHz					2.4 %	(ČSN EN ISO 15548-1)		
	Receiver – f ₀ , medium frequency	1 kHz	to	100			2.4 %			
	Receiver $-\Delta f$, bandwidth	1 kHz	to	100			2.5 %			
	Receiver - attenuator accuracy	1 KHZ	to	100	KHZ		5.7 %			
	receiver - attenuator accuracy							Comparison with a		
		0 dB	to	30	dB	1 kHz to 100 kHz	0.43 dB	reference attenuator (ČSN EN ISO 15548-1)		
8*	Digital ultrasonic defectoscopes							(A 04-55/21	
	Transmitter – Impulse voltage amplitude							Direct signal measurement with a reference oscilloscope	110133721	
		1 V	to	400	V		3.2 %	(ČSN EN ISO 22232-1)		
	Transmitter – Pulse rise time	0 ns	to	500	ns		2.7 % + 2.4 ns	(0011 211 100 22252 1)		
	Transmitter – Pulse duration	0 ns	to	500	ns		2.7% + 2.4 ns			
	Receiver – flm, lower limit frequency							Signal generation by a reference generator		
		0.1 MHz	to	25	MHz	0	3.3 %	(ČSN EN ISO 22232-1)		
	Receiver – fum, upper limit frequency	0.1 MHz	to		MHz	situt pro atrodition	3.3 %			
	Receiver – f0, medium frequency	0.1 MHz	to	25	MHz /	titul A TO	3.5 %			
	Receiver – Δf , bandwidth	0.1 MHz	to	25]	MHz/	8 6	4.7 %			

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Ord.	Calibrated quantity / Subject of calibration	Non	ninal r	ange	Parameter(s) of the meas. quantity	Lowest expanded measurement uncertainty specified ²	Calibration principle	Calibration procedure identification ³	Work
ber ¹		min. unit		max. unit					place
	Receiver – noise level						Direct signal measurement with a reference oscilloscope, Comparison with a reference attenuator		
	Receiver – gain linearity	10-12 V/√Hz	to	10-6 V/√Hz		2.7·10-9 V/√Hz	(ČSN EN ISO 22232-1) Comparison with a		
	Receiver – display vertical linearity	0 dB	to	70 dB		2.8 % + 0.2 dB	reference attenuator (ČSN EN ISO 22232-1)		
	Time base deviation	0 dB	to	70 dB		2.8 % + 0.2 dB	Signal generation by a		
		0.5 μs	to	2,000 μs		1.1 % + 0.05 μs	reference generator (ČSN EN ISO 22232-1)		

- Asterisk at the ordinal number identifies the calibrations, which the Laboratory is qualified to carry out outside the permanent laboratory premises.
- The expanded measurement uncertainty is in accordance with ILAC-P14 and EA-4/02 M part of CMC, and it is the lowest value of the respective uncertainty. If not stated otherwise, its coverage probability is approx. 95 %. If not stated otherwise, the uncertainty values stated without a unit are relative to the value measured. The uncertainty value stated herein is based on the best conditions achievable by the laboratory; the uncertainty value of a specific calibration may be higher, depending on the conditions of such a calibration. For identical extreme values of adjacent ranges, the lower uncertainty value always applies.
- If the document identifying the calibration procedure is dated, only these specific procedures are used. If the document identifying the calibration procedure is not dated, the latest edition of the specified procedure is used (including any changes).

Explanatory notes:

SW Screen Width

SH Screen Height

